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E. Millis  
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Alan G. Wood  
Tim J. Corbett  
Gary L. Chadwick  
Chender Huang  
Larry D. Kinsman

Continuation of Serial No. 08/192,023      Art Unit:  
filed February 3, 1994

Filing Date: July 10, 2000      Examiner:

For: Test Fixture And Test Method For Testing  
Semiconductor Dice (As Amended)

Attorney Docket No. 91-62.20

**PRELIMINARY AMENDMENT  
SUBMITTED WITH CONTINUING APPLICATION  
UNDER 37 CFR 1.53(b)  
July 10, 2000**

Commissioner of Patents and Trademarks  
BOX PATENT APPLICATION  
Washington, D.C. 20231

Sir:

This Preliminary Amendment is being filed with a continuing application under 37 CFR 1.53(b). Please amend the captioned case as follows.

In the Specification

Please change the title to --Test Fixture And Test Method For Testing Semiconductor Dice--.

On page 2, line 1, please add the following:

--Cross Reference To Related Applications

This application is a continuation of application serial no. 08/192,023, filed February 3, 1994, Patent No. 6,091,250, which is a division of application serial no.

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